

DRAWN

何秦芝

Sharon Ho

Specifica	tion f	or	Ap	prova	
	Date: 2017	7/03/16	<u> </u>		
Custor	ner:深圳臺	慶		_	
TAI-TECH P/N:	TMPA0603S	V-Serie	es(N)-D		
CUSTOMER P/N:					
DESCRIPTION:					
QUANTITY:		pcs			
REMARK:					
Cu	istomer Approval	Feedba	ack		
西北臺慶科技股份有限公司 TAI-TECH Advanced Electronics Co., Ltd <u>Headquarter:</u> NO.1 YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-M TAO-YUAN HSIEN, TAIWAN, R.O.C. TEL: +886-3-4641148 FAX: +886-3-4643565 http://www.tai-tech.com.tw E-mail: sales@tai-tech.com.tw	ЛЕI,				
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SMD Power Inductor

TMPA0603SV-Series(N)-D

	ECN HISTORY LIST								
REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN				
1.0	17/03/16	新發行	楊祥忠	詹偉特	何秦芝				
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注									

SMD Power Inductor

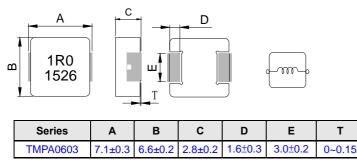
1. Features

- 1. Shielded construction.
- 2. Capable of corresponding high frequency (5MHz).
- 3. Low loss realized with low DCR.
- 4. High performance (Isat) realized by metal dust core.
- 5. Ultra low buzz noise, due to composite construction.
- 6. 100% Lead(Pb)-Free and RoHS compliant.
- 7. High reliability -Reliability test complied to AEC-Q200

2. Applications

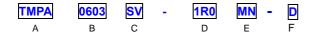
- 1. DC/DC converters in distributed power systems.
- 2. DC/DC converter for Field Programmable Gate Array(FPGA).
- 3. Battery powered devices.
- 4. Thin type on-board power supply module for exchanger.
- 5. VRM for server.
- 6. High current, low profile POL converters.
- 7. PDA/notebook/desktop/server and battery powered devices.

3. Dimensions



Unit:mm

4. Part Numbering



BxC

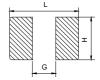
A: Series

- B: Dimension
- C: Type
- D: Inductance E: Inductance Tolerance
- F: Code

TMPA0603SV-Series(N)-D



Recommend PC Board Pattern



L(mm)	G(mm)	H(mm)			
8.0	3.7	3.4			
Note: 1 The above PCB layout reference only					

 Recommend solder paste thickness at 0.15mm and above.

5. Specification

Part Number	Inductance L0 A(uH) ±20%	Heat Rating Current DC Typ (A) Irms.	Saturation Current DC Typ (A)I sat	DCR (mΩ)Typ	DCR (mΩ)Max
TMPA0603SV-R15YN-D	0.15±30%	30	40	1.7	2.1
TMPA0603SV-R22MN-D	0.22	23	34	2	2.5
TMPA0603SV-R33MN-D	0.33	21	25	2.8	3.4
TMPA0603SV-R36MN-D	0.36	20	24	3.3	3.9
TMPA0603SV-R47MN-D	0.47	18	20	3.4	4
TMPA0603SV-R56MN-D	0.56	16.5	18	3.9	4.5
TMPA0603SV-R68MN-D	0.68	16	17	4.7	5.3
TMPA0603SV-R82MN-D	0.82	14	16	5.4	6
TMPA0603SV-1R0MN-D	1.00	12	15	6.7	7.4
TMPA0603SV-1R2MN-D	1.20	10	14	7.7	9.5
TMPA0603SV-1R5MN-D	1.50	10	14	10.2	12.1
TMPA0603SV-2R2MN-D	2.20	8	10	13.5	15
TMPA0603SV-2R7MN-D	2.70	7.2	9.8	17.3	20
TMPA0603SV-3R3MN-D	3.30	6.5	9.5	19	22
TMPA0603SV-4R7MN-D	4.70	5.5	6.5	28	33
TMPA0603SV-5R6MN-D	5.60	5.5	6	39	42
TMPA0603SV-6R8MN-D	6.80	4.5	6	43	50
TMPA0603SV-8R2MN-D	8.20	4.5	6	54	60
TMPA0603SV-100MN-D	10.0	4	5.5	62	68
TMPA0603SV-150MN-D	15.0	3	4.5	110	140
TMPA0603SV-220MN-D	22.0	2.5	3	150	190

Note:

1. Test frequency : Ls : 100KHz /1.0V.

2. All test data referenced to $25^\circ\!\!\mathbb{C}$ ambient.

3. Testing Instrument(or equ) : L: HP4284A,CH11025,CH3302,CH1320,CH1320S LCR METER / Rdc:CH16502,Agilent33420A MICRO OHMMETER.

4. Heat Rated Current (Irms) will cause the coil temperature rise approximately $\, \Delta T \, \text{of} \, 40^\circ \! \text{C}$

5. Saturation Current (Isat) will cause L0 to drop approximately 30%.

6. The part temperature (ambient + temp rise) should not exceed 155°C under worst case operating conditions. Circuit design, component, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.

7. Special inquiries besides the above common used types can be met on your requirement.

6. Material List

	NO	Items	Materials
Marking	1	Core	Alloy Powder .
630	2	Wire	Polyester Wire or equivalent.
	3	Clip	100% Pb free solder(Ni+SnPlating)
	4	Ink	Halogen-free ketone
1 2			

7. Reliability and Test Condition

Item	Performance	Test Condition
Operating temperature	-55~+155°C (Including self - temperature rise)	
Storage temperature and Humidity range	110~+40℃,50~60%RH (Product without taping) 255~+155℃ (on board)	
Electrical Performance	Test	
Inductance	Refer to standard electrical characteristics list.	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.
DCR		CH16502, Agilent33420A Micro-Ohm Meter.
Saturation Current (Isat) Approximately △L30%		Saturation DC Current (Isat) will cause L0 to drop $\bigtriangleup L(\%)$
Heat Rated Current (Irms)	Approximately △T40°C	Heat Rated Current (Irms) will cause the coil temperature rise $\triangle T(\mathbb{C})$. 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer
Reliability Test		
High Temperature Exposure(Storage)		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Temperature : 155±2℃(Inductor) Duration : 1000hrs Min. Measured at room temperature after placing for 24±2 hrs
Temperature Cycling		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Condition for 1 cycle Step1 : -55±2℃ 30min Min.(Inductor) Step2 : 155±2℃ transition time 1min MAX. Step3 : 155±2℃ 30min Min. Step4 : Low temp. transition time 1min MAX. Number of cycles : 1000
Moisture Resistance	Appearance : No damage. Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	 Measured at room temperature after placing for 24±2 hrs Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs. 3. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs,keep at 25°C for 2 hrs then keep at -10°C for 3 hrs 4. Keep at 25°C 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1–2 hrs.
Biased Humidity (AEC-Q200)		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Humidity : 85±3% R.H, Temperature : 85°C ±2°C Duration : 1000hrs Min with 100% rated current.
High Temperature Operational Life (AEC-Q200)		Measured at room temperature after placing for24±2 hrs Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Temperature : 155±2°C (Inductor) Duration : 1000hrs Min. with 100% rated current. Measured at room temperature after placing for24±2 hrs
Vibration		Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minute Equipment : Vibration checker Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations)。

ltem	Performance		Test Condition					
		ту		Peak value (g's)	durati	rmal ion (D) ns)	Wave form	Velocity change (Vi)ft/sec
Mechanical Shock		SI	MD	100		6	Half-sine	12.3
CHOCK		Le	ead	100		6	Half-sine	12.3
Resistance to Soldering Heat	ppearance:No damage. npedance:within±15% of initial value nductance:within±10% of initial value		er of he Tempe	each dire eat cycles erature(°C (solder te	s: 1 C)	along 3 Time(s) 10±1	Temperati ramp/imn and emei 25mm/s :	nersion sion rate
Thermal shock	exceed the specification value	J-STD Reflow Condit Step1 Step2 Step3 Numbe	020D0 Profile ion for : -55±2 : 155± : 155± : 155±	Classifica es 1 cycle 2°C 15± 2°C with 2°C 15± vcles : 3	ation 1min(Inc in 20Se 1min 300	ductor) c.	w for 2 time	s.(IPC/JEDEC
Resistance to Solvents	Appearance : No damage.	,	Add aq	queous w	rash che	emical - C	DKEM clea	n or equivalent.
ESD		0.53*\ 0.37*\	surge	rotage	ine 🗕 🗕	$T_d = discl$	ge time constant harge time const arge time ————————————————————————————————————	ine ine
Solderability	More than 95% of the terminal electrode should be covered with solder。	Prehea Solder Tempe Flux fo Dip tim	at: 150 : Sn96 rature r lead ie: 4±1	: 8 hours °C ,60sec 5.5% Ag3 : 245±5°(free: Ros sec. letely cov	.ം % Cu0.క ാം sin. 9.5%	5% %。	on	
Flammability	Electrical Test not required	V-0 c	or V-1 a	are acce	ptable			
Flammability	ероху	V-0 c	or V-1 a	are acce	ptable			

ltem	Performance	Test Condition
Board Flex		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Place the 100mm X 40mm board into a fixture similar to the one shown in below Figure with the component facing down. The apparatus shall consist of mechanical means to apply a force which will bend the board (D) $x = 2$ mm minimum. The duration of the applied forces shall be 60 (+ 5) sec. The force is to be applied only once to the board.
	Appearance : No damage.	Profee downed torseling lieros
		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020D Classification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a 17.7 N (1.8 Kg) force to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to thecomponent being tested.
Terminal Strength (SMD)		substrate press tool shear force

Note : When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition.

P7

8. Soldering and Mounting

(1) Soldering

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. TAI-TECH terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

(2) Solder re-flow:

Recommended temperature profiles for re-flow soldering in Figure 1.

(3) Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

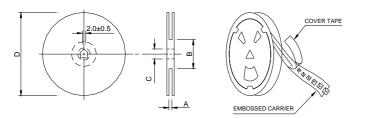
- Preheat circuit and products to 150°C
 · Never contact the ceramic with the iron tip
 · 355°C tip temperature (max)
 · 1.0mm tip diameter (max)
- Use a 20 watt soldering iron with tip diameter of 1.0mm
 Limit soldering time to 4~5sec.
- Reflow Soldering Iron Soldering PRE-HEATING SOLDERING NATURAL PRE-HEATING SOLDERING NATURAL COOLING within 4~5s TP(260°C / 10s max. 350 TEMPERATURE(°C) tp(245°C / 20~40s.) **FEMPERATURE(°C)** 217 60~150s 150 60~180s Gradual cooling Over 60s 480s max TIME(sec.) TIME(sec.) Iron Soldering times: 1 times max. Reflow times: 3 times max. Fig.1 Fig.2

9. Friendly reminder

- (1) When there are questions concerning measurement result : measurement shall be made after 48 \pm 2 hours of recovery under the standard condition
- (2) This power choke coil itself does not have any protective function in abnormal condition such as overload, short-circuit and open-circuit conditions, etc. Therefore, it shall be confirmed as the end product that there is no risk of smoking, fire, dielectric withstand voltage, insulation resistance, etc. in abnormal conditions to provide protective devices and/or protection circuit in the end product.
- (3) When this power choke coil was used in a similar or new product to the original one, sometimes it might not be able to satisfy the specifications due to different condition of use.
- (4) Dielectric withstanding test with higher voltage than specific value will damage insulating material and shorten its life.
- (5) This power choke coil must not be used in wet condition by water, coffee or any liquid because insulation strength becomes very low in this condition.
- (6) Please consult our company to confirm the reliability of the process required to wash or use or exposure to a chemical solvent used in this product.

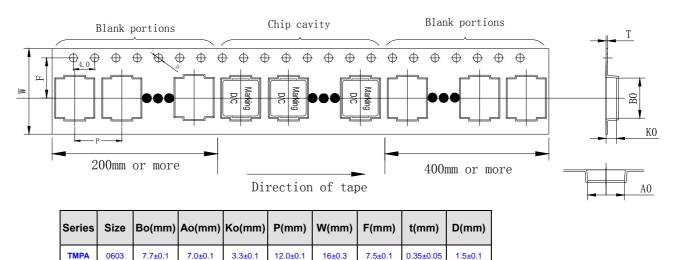
10. Packaging Information

(1) Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
13"x16mm	16.4+2/-0	100±2	13+0.5/-0.2	330

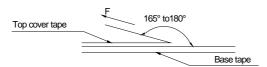
(2) Tape Dimension



(3) Packaging Quantity

TMPA	0603
Chip / Reel	1000
Inner box	2000
Carton	8000

(4) Tearing Off Force



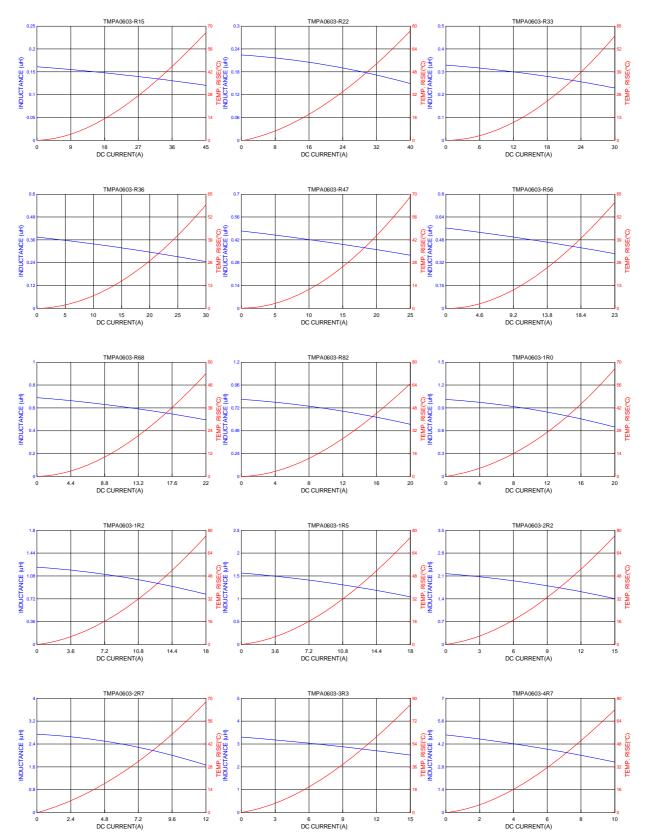
The force for tearing off cover tape is 10 to 130 grams in the arrow direction under the following conditions(referenced ANSI/EIA-481-C-2003 of 4.11 standard).

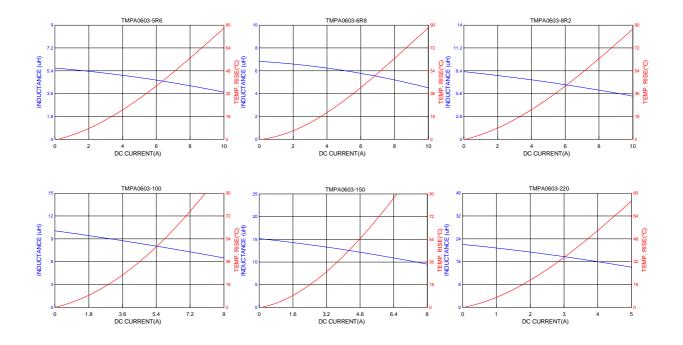
Room Temp.	oom Temp. Room Humidity		Tearing Speed	
(°C)	(%)	(hPa)	mm/min	
5~35	45~85	860~1060	300	

Application Notice

- Storage Conditions(component level)
- To maintain the solderability of terminal electrodes:
- 1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 2. Temperature and humidity conditions: Less than 40 $^\circ\!\mathrm{C}$ $\,$ and 60% RH.
- 3. Recommended products should be used within 12 months form the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

11. Typical Performance Curves







號碼(No.): CE/2016/A0549

日期(Date): 2016/10/13

頁數(Page): 1 of 12

Test Report

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

(耀鑽科技股份有限公司 / YOSONIC TECHNOLOGY CO., LTD.)

(慶邦電子元器件(泗洪)有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.)

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(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA) (桃園市中壢區中壢工業區長春六路15號 / NO. 15, CHANGCHUN 6TH RD., JHONGLI CITY, TAOYUAN COUNTY 320, TAIWAN) (中國江蘇省宿遷市泗洪縣經濟開發區杭州路南側建設北路東側 / THE SOUTH HANGZHOU ROAD AND THE EAST JIANSHE ROAD, ECONOMIC DEVELOPMENT ZONE, SIHONG COUNTY, SUQIANCITY, JIANGSU PROVINCE, P. R. CHINA)

以下測試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by/on behalf of the applicant as):

様品名稱(Sample Description)
: SMD POWER INDUCTOR
樣品型號(Style/Item No.)
: TMPB、TMPC、TMPA、TMPF、SLPI、SMPI、EPI(ePI)、VMPI、MLPI SERIES
收件日期(Sample Receiving Date)
: 2016/10/05
: 2016/10/05 TO 2016/10/13

測試需求(Test Requested):

(1) 依據客戶指定,參考RoHS2011/65/EU Annex II及其修訂指令(EU) 2015/863測試鎬、鉛、汞、六價鉻、多溴聯 苯、多溴聯苯醚, DBP, BBP, DEHP, DIBP. (As specified by client, with reference to RoHS 2011/65/EU Annex II and amending Directive (EU) 2015/863 to determine Cadmium, Lead, Mercury, Cr(VI), PBBs, PBDEs, DBP, BEP, DEHP, DIBP contents in the submitted sample.)

(2) 其他測試項目請見下一頁 . (Please refer to next pages for the other item(s).)

测试结果(Test Results) : 請見下一頁 (Please refer to next pages).



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SGS Taiwan Ltd. 台灣檢驗科技服份有限公司 25, Wu Chyvan 7th Road, New Taipei Industrial Park, Wu Ku District, New Taipei City, Taiwan 航北市五级區新北進業園區五種七路25號



Test Report

號碼(No.): CE/2016/A0549

日期(Date): 2016/10/13

頁數(Page): 2 of 12

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<u>測試結果(Test Results)</u>

測試部位(PART NAME)No.1 : 整體混

整體混測 (MIXED ALL PARTS)

测試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鎘 / Cadmium (Cd)	mg/kg	参考IEC 62321-5 (2013),以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-5 (2013) and performed by ICP-AES.	2	n. d.
鉛 / Lead (Pb)	mg/kg ·	参考IEC 62321-5 (2013),以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-5 (2013) and performed by ICP-AES.	2	n. d.
汞 / Mercury (Hg)	mg/kg	参考IEC 62321-4 (2013),以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-4 (2013) and performed by ICP-AES.	2	n.d.
六價鉻 / Hexavalent Chromium Cr(VI)	mg/kg	參考IEC 62321 (2008),以UV-VIS檢 測. / With reference to IEC 62321 (2008) and performed by UV-VIS.	2	n. d.
鈹 / Beryllium (Be)	mg/kg	参考US EPA 3052 (1996),以感應耦合 電漿原子發射光譜儀檢測. / With reference to US EPA 3052 (1996). Analysis was performed by ICP-AES.	2	n. d.
绨 / Antimony (Sb)	mg/kg	參考US EPA 3052 (1996),以感應耦合 電漿原子發射光譜儀檢測. / With reference to US EPA 3052 (1996). Analysis was performed by ICP-AES.	2	n. d.

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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

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(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA) (桃園市中壢區中壢工業區長春六路15號 / NO. 15, CHANGCHUN 6TH RD., JHONGLI CITY, TAOYUAN COUNTY 320, TAIWAN) (中國江蘇省宿還市泗洪縣經濟開發區杭州路南側建設北路東側 / THE SOUTH HANGZHOU ROAD AND THE EAST JIANSHE ROAD, ECONOMIC DEVELOPMENT ZONE, SIHONG COUNTY, SUQIANCITY, JIANGSU PROVINCE, P. R. CHINA)

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限值 (MDL)	結果 (Result) No.1
六溴環十二烷及所有主要被辨別出的異構 物 / Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified (α - HBCDD, β - HBCDD, γ - HBCDD) (CAS No.: 25637-99-4 and 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8))	mg/kg	參考IEC 62321 (2008),以氣相層析/ 質譜儀檢測. / With reference to IEC 62321 (2008). Analysis was performed by GC/MS.	5	n. d.
鹵素 / Halogen				
鹵素(氟)/ Halogen-Fluorine (F) (CAS No.: 14762-94-8)	mg/kg	參考BS EN 14582(2007),以離子層析 儀分析. / With reference to BS EN 14582(2007). Analysis was performed by IC.	50	n.d.
鹵素(氯)/ Halogen-Chlorine(C1) (CAS No.: 22537-15-1)	mg/kg		50	n. d.
鹵素(溴)/ Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg		50	n, d.
鹵素 (碘) / Halogen-Iodine (I) (CAS No.: 14362-44-8)	mg/kg		50	n. d.
鄰苯二甲酸丁苯甲酯 / BBP (Butyl Benzyl phthalate) (CAS No.: 85-68-7)	mg/kg	參考IEC 62321-8/CD (2013),以氣相 層析儀/質譜儀檢測. / With reference to IEC 62321-8/CD (2013). Analysis was performed by GC/MS.	50	n. d.
鄰苯二甲酸二丁酯 / DBP (Dibutyl phthalate) (CAS No.: 84-74-2)	mg/kg		50	n. d.
鄰苯二甲酸二 (2-乙基己基)酯 / DEHP (Di- (2-ethylhexyl) phthalate) (CAS No.: 117-81-7)	mg/kg		50	n. d.

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Test Report

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鄰苯二甲酸二異丁酯 / DIBP (Di-isobuty1 phthalate) (CAS No.: 84-69-5)	mg/kg	參考IEC 62321-8/CD (2013),以魚相 層析儀/質譜儀檢測. / With reference to IEC 62321-8/CD (2013). Analysis was performed by GC/MS.	50	n. d.
鄉苯二甲酸二異癸酯 / DIDP (Di-isodecyl phthalate) (CAS No.: 26761-40-0; 68515-49-1)	mg/kg		50	n. d.
鄰苯二甲酸二異壬酯 / DINP (Di-isonony1 phthalate) (CAS No.: 28553-12-0; 68515-48-0)	mg/kg		50	n. d.
鄰苯二甲酸二正辛酯 / DNOP (Di-n-octyl phthalate) (CAS No.: 117-84-0)	mg/kg		50	n. d.
鄭苯二甲酸二正己酯 / DNHP (Di-n-hexyl phthalate) (CAS No.: 84-75-3)	mg/kg		50	n. d.
鄰苯二甲酸二戊酯 / Di-n-pentyl phthalate (CAS No.: 131-18-0)	mg/kg		50	n. d.
多溴聯苯總和 / Sum of PBBs	_mg/kg	参考IEC 62321-6 (2015),以氣相層析 /質譜儀檢測. / With reference to IEC 62321-6 (2015) and performed by GC/MS.	-	n. d.
一溴聯苯 / Monobromobiphenyl	mg/kg		5	n. d.
二溴聯苯 / Dibromobiphenyl	mg/kg		5	n. d.
三溴聯苯 / Tribromobiphenyl	mg/kg		5	n. d.
四溴聯苯 / Tetrabromobiphenyl	mg/kg		5	n. d
五溴聯苯 / Pentabromobiphenyl	mg/kg		5	n. d.
六溴聯苯 / Hexabromobiphenyl	mg/kg		5	n. d.
セ溴聯苯 / Heptabromobiphenyl	mg/kg		5	n.d.
八溴聯苯 / Octabromobiphenyl	mg/kg		5	n. d.
九溴聯苯 / Nonabromobiphenyl	mg/kg		5	_n.d.
十溴聯苯 / Decabromobiphenyl	ng/kg		5	n.d.

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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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測試項目 (Test Items)	單位 (Unit)	测試方法 (Method)	方法偵測 極限值 (MDL)	結果 (Result)
				No. 1
多溴聯苯醚總和 / Sum of PBDEs	mg/kg	參考IEC 62321-6 (2015),以魚相層析 /質譜儀檢測. / With reference to IEC 62321-6 (2015) and performed by GC/MS.		n.d.
一溴聯苯醚 / Monobromodiphenyl ether	mg/kg		5	n. d.
二溴聯苯醚 / Dibromodiphenyl ether	mg/kg		5	n.d.
三溴聯苯醚 / Tribromodiphenyl ether	mg/kg		5	n.d.
四溴聯苯醚 / Tetrabromodiphenyl ether	mg/kg		5	n.d.
五溴聯苯醚 / Pentabromodiphenyl ether	mg/kg		5	n. d.
六溴聯苯醚 / Hexabromodiphenyl ether	mg/kg		. 5	n.d.
七溴聯苯醚 / Heptabromodiphenyl ether	mg/kg		5	n. d.
八溴聯苯醚 / Octabromodiphenyl ether	mg/kg		5	n. d.
九溴聯苯醚 / Nonabromodiphenyl ether	mg/kg		5	n. d.
十溴聯苯醚 / Decabromodiphenyl ether	mg/kg		5	n. d.

備註(Note):

1. mg/kg = ppm; 0.1wt% = 1000ppm

2. n.d. = Not Detected (未檢出)

3. MDL = Method Detection Limit (方法偵測極限值)

4. "-" = Not Regulated (無規格值)

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Test Report

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

(耀鑽科技股份有限公司 / YOSONIC TECHNOLOGY CO., LTD.)

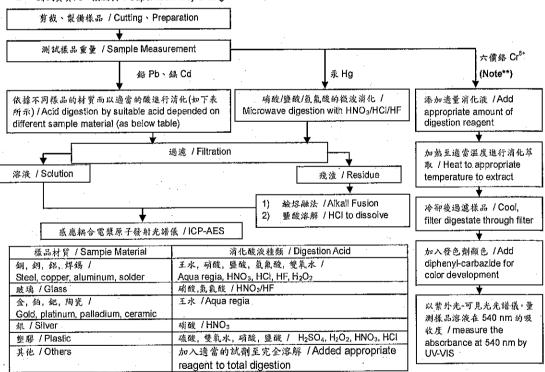
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重金屬流程圖 / Analytical flow chart of Heavy Metal (IEC 62321)

- 根據以下的流程圖之條件,樣品已完全溶解。(六價鋒測試方法除外) /
- These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr6+ test method excluded)
- 测试人員:王志瑋 / Technician: JR Wang
- 测試負責人:張啟興 / Supervisor: Troy Chang



Note**: (1) 針對非金屬材料加入鹼性消化液,加熱至 90~95℃ 萃取. / For non-metallic material, add alkaline digestion reagent and heat to 90~95℃.

(2) 針對金屬材料加入純水,加熱至沸腾萃取. / For metallic material, add pure water and heat to boiling

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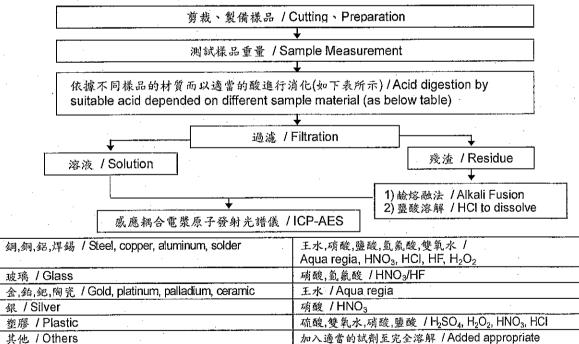
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根據以下的流程圖之條件,樣品已完全溶解。 / These samples were dissolved totally by pre-conditioning method according to below flow chart.

- 測試人員:王志瑋 / Technician: JR Wang
- 測試負責人:張啟興 / Supervisor: Troy Chang

元素以 ICP-AES 分析的消化流程圖

(Flow Chart of digestion for the elements analysis performed by ICP-AES)



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reagent to total digestion



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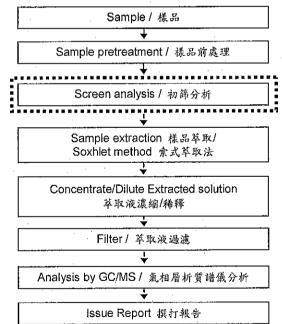
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多溴聯苯/多溴聯苯醚分析流程圖 / Analytical flow chart - PBB/PBDE

■ 測試人員:凃雅苓 / Technician: Yaling Tu

■ 測試負責人:張啟興 / Supervisor: Troy Chang

初次测試程序 / First testing process ______ 選擇性篩檢程序 / Optional screen process _____ 確認程序 / Confirmation process _____



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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

(耀鑽科技股份有限公司 / YOSONIC TECHNOLOGY CO., LTD.)

(慶邦電子元器件(泗洪)有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.)

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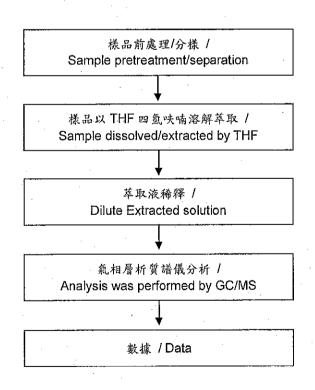
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<u>可塑劑分析流程圖 / Analytical flow chart - Phthalate</u>

■ 测試人員:徐毓明 / Technician: Andy Shu

■ 测試負責人:張啟興 / Supervisor : Troy Chang

【测試方法/Test method: IEC 62321-8】



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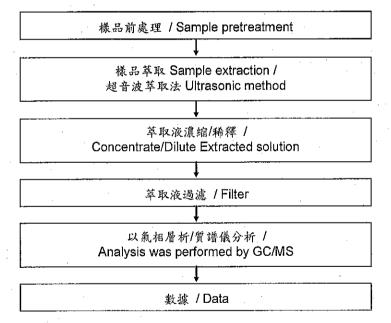
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六溴環十二烷分析流程圖 / Analytical flow chart - HBCDD

- 測試人員:涂雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang



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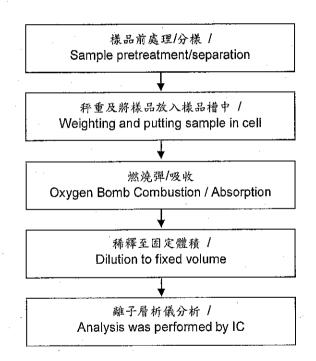
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鹵素分析流程圖 / Analytical flow chart - Halogen

■ 测試人員:陳恩臻 / Technician: Rita Chen

■ 測試負責人:張啟興 / Supervisor: Troy Chang



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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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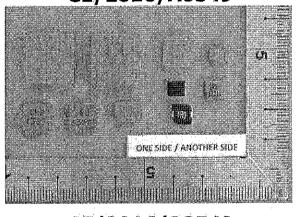
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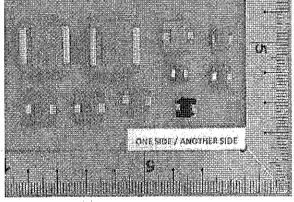
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> * 照片中如有箭頭標示,則表示為實際檢測之樣品/部位. * (The tested sample / part is marked by an arrow if it's shown on the photo.) CE/2016/A0549



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